

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/679,555 | Applicant(s)/Patent Under Reexamination WAFZIG ET AL. | |
| | Examiner Roger L Pang | Art Unit 3681 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| | A | US-5,238,460 | 08-1993 | Esaki et al. | 475/216 |
| | B | US-5,453,061 | 09-1995 | Fellows, Thomas G. | 475/215 |
| | C | US-6,036,616 | 03-2000 | McCarrick et al. | 475/214 |
| | D | US-5,931,760 | 08-1999 | Beim et al. | 475/207 |
| | E | US-6,155,951 | 12-2000 | Kuhn et al. | 475/216 |
| | F | US-6,171,210 | 01-2001 | Miyata et al. | 475/216 |
| | G | US-6,251,039 | 06-2001 | Koga, Hidetaka | 475/216 |
| | H | US-6,561,942 | 05-2003 | Wehking, Jeffrey Bodley | 475/216 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.